Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,103	NG ET AL.	
Examiner	Art Unit	
Jeffrey D. Lane	2828	

SEARCHED			
Class	Subclass	Date	Examiner
372	20	7/27/2007	JL
			:
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			7
			<del>                                     </del>
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
micro resonator with a grating	7/27/2006	JL
Different materials for waveguide and resonators	7/27/2007	JL
GalnAsP/InP on silicon	7/27/2006	JL
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